

**FCC Part 15B**  
**Measurement and Test Report**  
**For**  
**Verykool USA Inc**  
**4350 Executive Dr. #100, San Diego, CA 92121, USA**

**FCC ID: WA6I320**

<b>Test Standards:</b>	<u>FCC Part 15 Subpart B</u>
<b>Product Description:</b>	<u>Mobile Phone</u>
<b>Tested Model:</b>	<u>I320</u>
<b>Report No.:</b>	<u>STR12078156E-3</u>
<b>Tested Date:</b>	<u>2012-07-13 to 2012-07-26</u>
<b>Issued Date:</b>	<u>2012-07-30</u>
<b>Tested By:</b>	<u>Vigoss Xiong / Engineer</u> <i>Vigoss Xiong</i>
<b>Reviewed By:</b>	<u>Lahm Peng / EMC Manager</u> <i>Lahm peng</i>
<b>Approved &amp; Authorized By:</b>	<u>Jandy so / PSQ Manager</u> <i>Jandyso</i>
<b>Prepared By:</b>	
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Note: This test report is limited to the above client company and the product model only. It may not be duplicated without prior permitted by SEM.Test Compliance Service Co., Ltd

**TABLE OF CONTENTS**

**1. GENERAL INFORMATION.....3**

1.1 PRODUCT DESCRIPTION FOR EQUIPMENT UNDER TEST (EUT).....3

1.2 TEST STANDARDS.....4

1.3 TEST METHODOLOGY .....4

1.4 TEST FACILITY .....4

1.5 EUT SETUP AND OPERATION MODE .....5

**2. SUMMARY OF TEST RESULTS .....6**

**3. CONDUCTED EMISSIONS .....7**

3.1 MEASUREMENT UNCERTAINTY .....7

3.2 TEST EQUIPMENT LIST AND DETAILS .....7

3.3 TEST PROCEDURE.....7

3.4 BASIC TEST SETUP BLOCK DIAGRAM.....7

3.5 ENVIRONMENTAL CONDITIONS .....8

3.6 SUMMARY OF TEST RESULTS/PLOTS .....8

3.7 CONDUCTED EMISSIONS TEST DATA.....8

**4. RADIATED EMISSIONS.....11**

4.1 MEASUREMENT UNCERTAINTY .....11

4.2 TEST EQUIPMENT LIST AND DETAILS .....11

4.3 TEST PROCEDURE.....11

4.4 TEST RECEIVER SETUP .....12

4.5 CORRECTED AMPLITUDE & MARGIN CALCULATION.....12

4.6 ENVIRONMENTAL CONDITIONS .....12

4.7 SUMMARY OF TEST RESULTS/PLOTS .....12

# 1. GENERAL INFORMATION

## 1.1 Product Description for Equipment Under Test (EUT)

### Client Information

Applicant: Verykool USA Inc  
 Address of applicant: 4350 Executive Dr. #100, San Diego, CA 92121, USA  
 Manufacturer: Shenzhen Konka Telecommunications Technology Co., Ltd  
 Address of manufacturer: Overseas Chinese towns, NanShan District, Shenzhen

General Description of EUT	
Product Name:	Mobile Phone
Trade Name:	verykool
Model No.:	I320
Adding Model(s):	/
<i>Note: The test data is gathered from a production sample, provided by the manufacturer.</i>	

Technical Characteristics of EUT	
Rated Voltage:	AC 100-240V
Rated Current:	500mA
Rated Power:	2.5W
Power Adapter Model:	KTC-07USB-D
Highest Internal Frequency:	26MHz
Classification of ITE:	B
Support Interface:	USB

## 1.2 Test Standards

The following report is prepared on behalf of the Verykool USA Inc in accordance with Part 2, Subpart J, and Part 15, Subparts A and B of the Federal Communication Commissions rules.

The objective is to determine compliance with FCC Part 15, Subpart B, and section 15.205, 15.107, and 15.109 rules.

**Maintenance of compliance** is the responsibility of the manufacturer. Any modification of the product, which result in lowering the emission, should be checked to ensure compliance has been maintained.

## 1.3 Test Methodology

All measurements contained in this report were conducted with ANSI C63.4-2003, American National Standard for Methods of Measurement of Radio-Noise Emissions from Low-Voltage Electrical and Electronic Equipment in the range of 9 kHz to 40 GHz.

## 1.4 Test Facility

- **FCC – Registration No.: 994117**

SEM.Test Compliance Services Co., Ltd. EMC Laboratory has been registered and fully described in a report filed with the (FCC) Federal Communications Commission. The acceptance letter from the FCC is maintained in our files and the Registration is 994117.

- **Industry Canada (IC) Registration No.: 7673A**

The 3m Semi-anechoic chamber of SEM.Test Compliance Services Co., Ltd. has been registered by Certification and Engineering Bureau of Industry Canada for radio equipment testing with Registration No.: 7673A.

- **CNAS Registration No.: L4062**

Shenzhen SEM.Test Electronics Service Co., Ltd. is a testing organization accredited by China National Accreditation Service for Conformity Assessment (CNAS) according to ISO/IEC 17025. The accreditation certificate number is L4062. All measurement facilities used to collect the measurement data are located at 3/F, Jinbao Commerce Building, Xin'an Fanshen Road, Bao'an District, Shenzhen, P.R.C (518101)

### 1.5 EUT Setup and Operation Mode

The equipment under test (EUT) was configured to measure its highest possible emission level. The test modes were adapted according to the operation manual for use, more detailed description as follows:

Test Mode List:

Test Mode	Description	Remark
TM1	Charging and Playing	/
TM2	Downloading	/
TM3	/	/
TM4	/	/

EUT Cable List and Details

Cable Description	Length (M)	Shielded/Unshielded	With Core/Without Core
USB Cable	1.0	Shielded	Without Core
Earphone Cable	1.2	Unshielded	Without Core

Auxiliary Equipment List and Details

Description	Manufacturer	Model	Serial Number
Notebook	SAMSUNG	NP-R20	124V93FP300082V

Special Cable List and Details

Cable Description	Length (M)	Shielded/Unshielded	With Core/Without Core
/	/	/	/

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## 2. SUMMARY OF TEST RESULTS

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<b>FCC Rules</b>	<b>Description of Test Item</b>	<b>Result</b>
§ 15.107 (a)	Conducted Emissions	Compliant
§ 15.109 (a)	Radiated Emissions	Compliant

N/A: not applicable

### 3. Conducted Emissions

#### 3.1 Measurement Uncertainty

Base on NIS 81, The Treatment of Uncertainty in EMC Measurements, the best estimate of the uncertainty of any conducted emissions measurement is  $\pm 2.88$  dB.

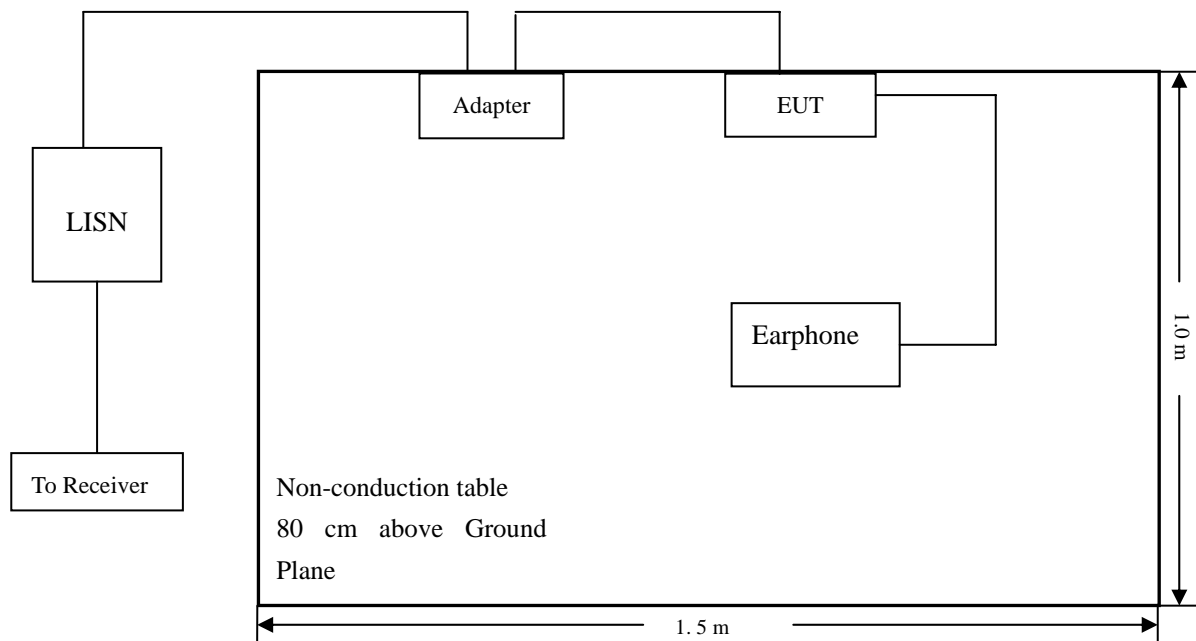
#### 3.2 Test Equipment List and Details

Description	Manufacturer	Model	Serial Number	Cal. Date	Due. Date
EMI Test Receiver	Rohde & Schwarz	ESPI	101611	2012-03-28	2013-03-27
L.I.S.N	Schwarz beck	NSLK8126	8126-224	2012-03-28	2013-03-27
Pulse Limiter	Rohde & Schwarz	ESH3-Z2	100911	2012-03-28	2013-03-27

#### 3.3 Test Procedure

Test is conducting under the description of ANSI C63.4-2003, American National Standard for Methods of Measurement of Radio-Noise Emissions from Low-Voltage Electrical and Electronic Equipment in the range of 9 kHz to 40 GHz.

#### 3.4 Basic Test Setup Block Diagram



### 3.5 Environmental Conditions

Temperature:	23 °C
Relative Humidity:	52%
ATM Pressure:	1011 mbar

### 3.6 Summary of Test Results/Plots

According to the data in section 3.7, the EUT complied with the FCC Part 15.107(a) Conducted margin for a Class B device, with the *worst* margin reading of:

**-2.06 dB $\mu$ V at 0.33 MHz in the Neutral, Ave detector, 0.15-30MHz**

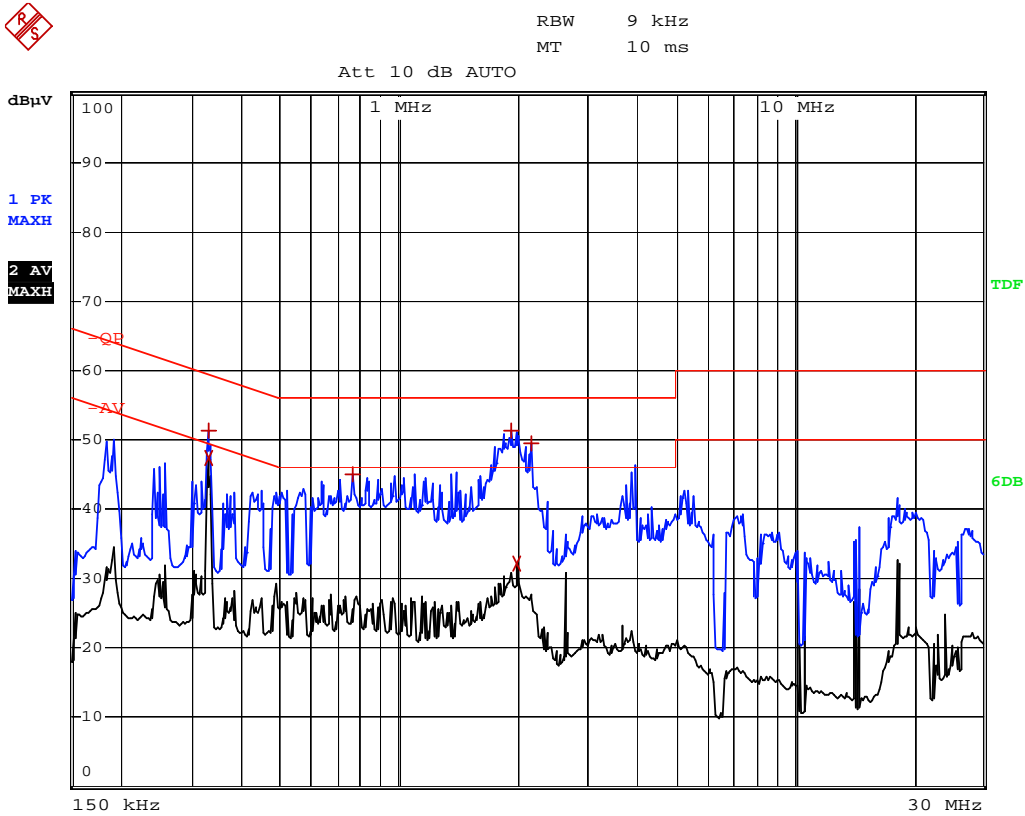
### 3.7 Conducted Emissions Test Data



**Plot of Conducted Emissions Test Data**

EUT: *Mobile Phone*  
 Tested Model: *I320*  
 Operating Condition: *Charging and Playing*  
 Comment: *AC 120V/60Hz*

Test Specification: *Neutral*



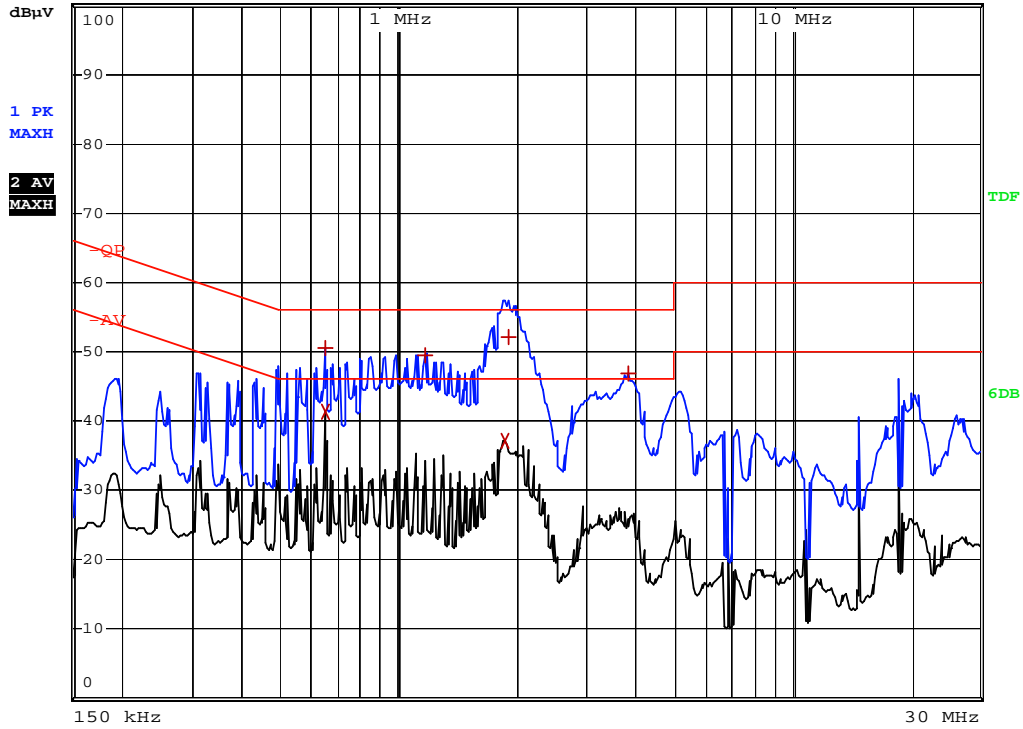
EDIT PEAK LIST (Prescan Results)			
Trace1:	-QP		
Trace2:	-AV		
Trace3:	---		
TRACE	FREQUENCY	LEVEL dBµV	DELTA LIMIT dB
1 Max Peak	330 kHz	51.30	-8.14
2 Average	330 kHz	47.38	-2.06
1 Max Peak	766 kHz	44.98	-11.01
1 Max Peak	1.934 MHz	51.35	-4.64
2 Average	1.978 MHz	32.02	-13.97
1 Max Peak	2.166 MHz	49.50	-6.49

Test Specification: Line



RBW 9 kHz  
MT 15 s

Att 10 dB AUTO



EDIT PEAK LIST (Prescan Results)			
Trace1:	-QP		
Trace2:	-AV		
Trace3:	---		
TRACE	FREQUENCY	LEVEL dBµV	DELTA LIMIT dB
1 Max Peak	650 kHz	50.54	-5.45
2 Average	650 kHz	41.21	-4.78
1 Max Peak	1.174 MHz	49.55	-6.44
2 Average	1.862 MHz	37.00	-8.99
1 Quasi Peak	1.902 MHz	52.14	-3.85
1 Max Peak	3.842 MHz	46.73	-9.26

## 4. Radiated Emissions

### 4.1 Measurement Uncertainty

Base on NIS 81, The Treatment of Uncertainty in EMC Measurements, the best estimate of the uncertainty of any radiation emissions measurement is  $\pm 5.10$  dB.

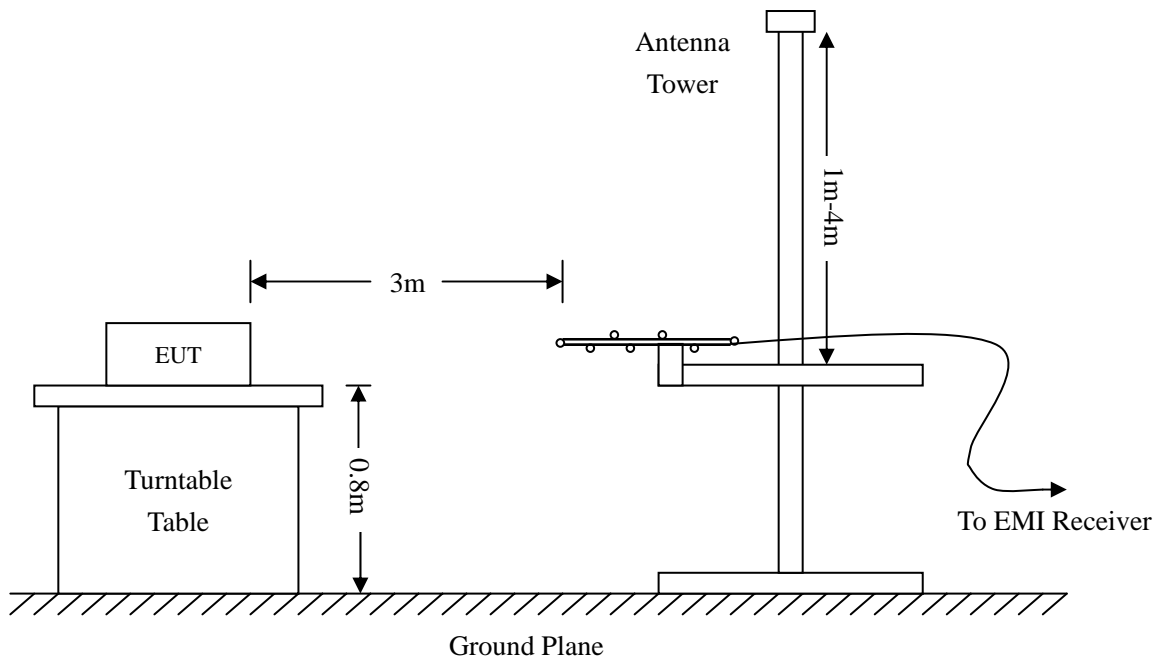
### 4.2 Test Equipment List and Details

Description	Manufacturer	Model	Serial Number	Cal. Date	Due. Date
Spectrum Analyzer	R&S	FSP	836079/035	2012-03-28	2013-03-27
EMI Test Receiver	R&S	ESVB	825471/005	2012-03-28	2013-03-27
Pre-amplifier	Agilent	8447F	3113A06717	2012-03-28	2013-03-27
Pre-amplifier	Compliance Direction	PAP-0118	24002	2012-03-28	2013-03-27
Trilog Broadband Antenna	SCHWARZBECK	VULB9163	9163-333	2012-02-25	2013-02-24
Horn Antenna	ETS	3117	00086197	2012-02-25	2013-02-24

### 4.3 Test Procedure

The setup of EUT is according with per ANSI C63.4-2003 measurement procedure. The specification used was with the FCC Part 15.109 Limit.

The external I/O cables were draped along the test table and formed a bundle 30 to 40 cm long in the middle. The spacing between the peripherals was 10 cm.



#### 4.4 Test Receiver Setup

During the radiated emission test for above 1GHz, the test receiver was set with the following configurations:

For peak detector:

RBW = 1000kHz, VBW = 3000kHz, Sweep Time = Auto

For average detector:

RBW = 1000kHz, VBW = 10Hz, Sweep Time = Auto

#### 4.5 Corrected Amplitude & Margin Calculation

The Corrected Amplitude is calculated by adding the Antenna Factor and the Cable Factor, and subtracting the Amplifier Gain from the Amplitude reading. The basic equation is as follows:

$$\text{Corr. Ampl.} = \text{Indicated Reading} - \text{Corr. Factor}$$

The “**Margin**” column of the following data tables indicates the degree of compliance with the applicable limit. For example, a margin of -6dB $\mu$ V means the emission is 6dB $\mu$ V below the maximum limit for a Class B device. The equation for margin calculation is as follows:

$$\text{Margin} = \text{Corr. Ampl.} - \text{FCC Part 15.109(a) Limit}$$

#### 4.6 Environmental Conditions

Temperature:	23 °C
Relative Humidity:	55 %
ATM Pressure:	1011 mbar

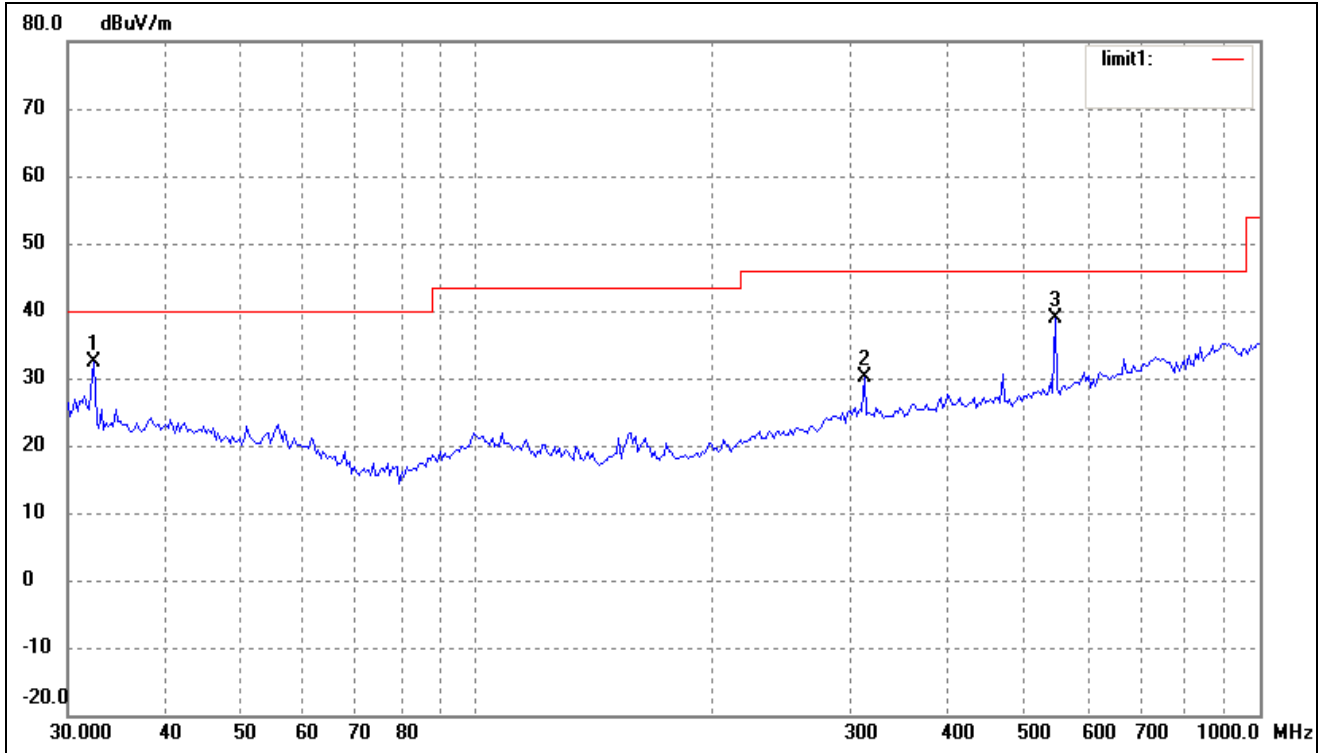
#### 4.7 Summary of Test Results/Plots

According to the data, the EUT complied with the FCC Part 15.109(a) rule, and had the worst margin of:

**-2.20 dB $\mu$ V at 30.0000 MHz in the Vertical polarization, Charging and Playing mode 30 MHz to 1 GHz,  
3Meters**  
**-4.13 dB $\mu$ V at 547.0977 MHz in the Horizontal polarization, Downloading mode, 30 MHz to 1 GHz,  
3Meters**

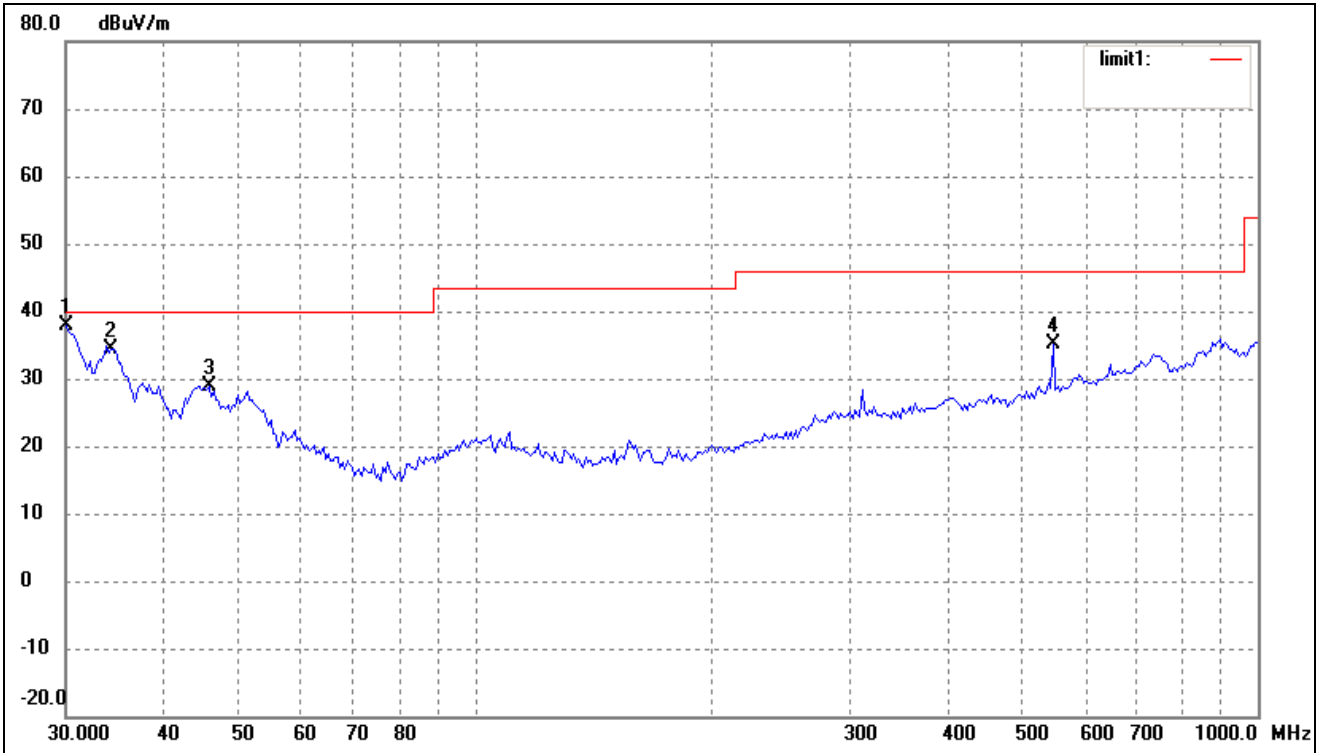
**Plot of Radiated Emissions Test Data**

EUT: *Mobile Phone*  
 Tested Model: *I320*  
 Operating Condition: *Charging and Playing*  
 Comment: *AC 120V/60Hz*  
  
 Test Specification: *Horizontal*



No.	Frequency (MHz)	Reading (dBuV/m)	Correct Factor(dB)	Result (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Degree (°)	Height (cm)	Remark
1	32.4059	23.98	8.44	32.42	40.00	-7.58	58	150	QP
2	312.1794	19.75	10.36	30.11	46.00	-15.89	326	100	QP
3	547.0977	25.62	13.19	38.81	46.00	-7.19	29	120	QP

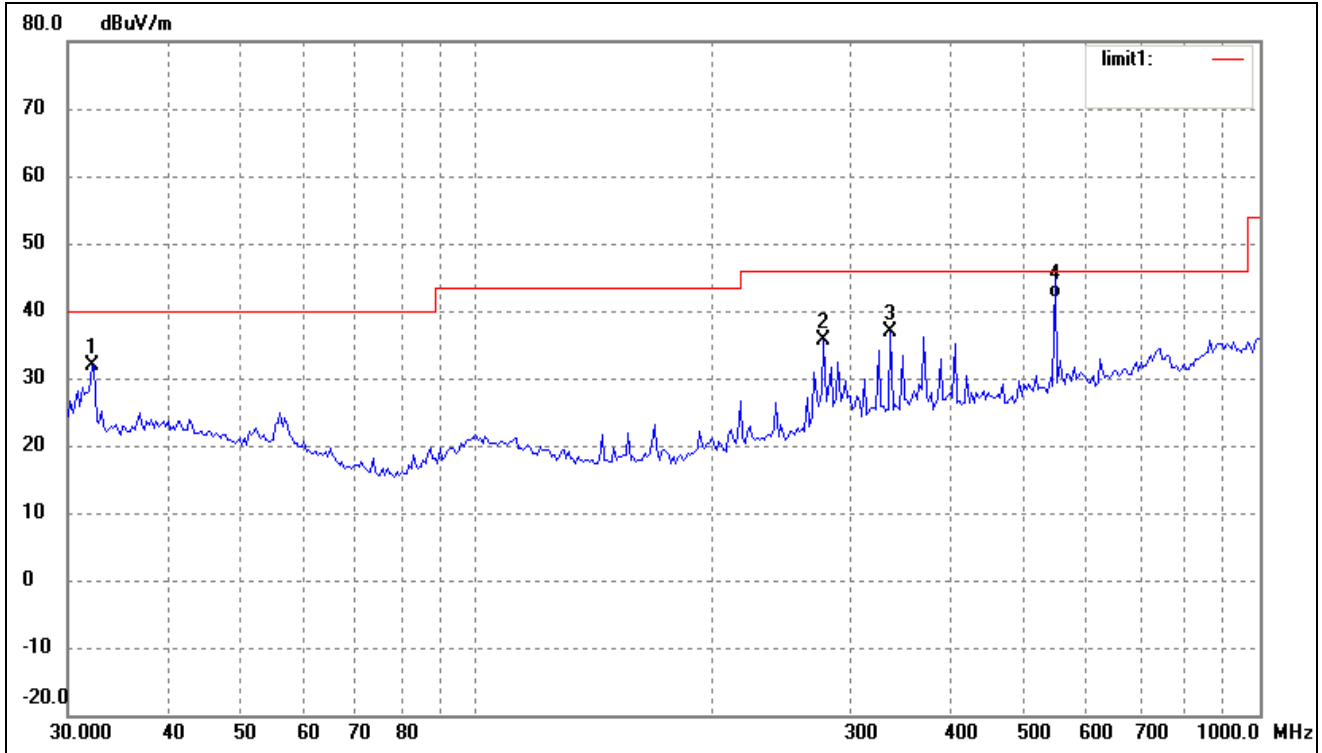
Test Specification: Vertical



No.	Frequency (MHz)	Reading (dBuV/m)	Correct Factor(dB)	Result (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Degree (°)	Height (cm)	Remark
1	30.0000	29.76	8.04	37.80	40.00	-2.20	51	100	peak
2	34.2760	25.60	8.76	34.36	40.00	-5.64	308	100	peak
3	45.6948	20.91	7.94	28.85	40.00	-11.15	120	100	peak
4	547.0977	21.93	13.19	35.12	46.00	-10.88	359	100	peak

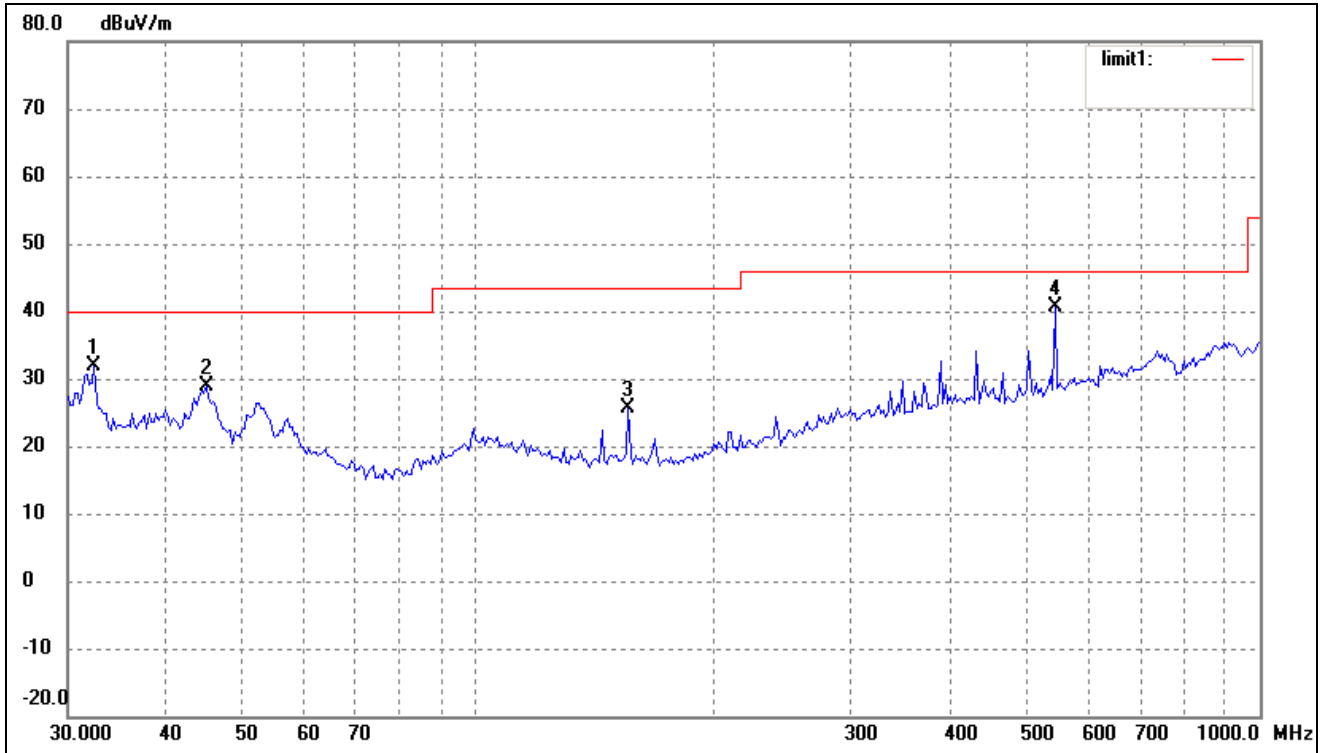
**Plot of Radiated Emissions Test Data**

EUT: *Mobile Phone*  
 Tested Model: *I320*  
 Operating Condition: *Downloading*  
 Comment: *Connect to PC*  
  
 Test Specification: *Horizontal*



No.	Frequency (MHz)	Reading (dBuV/m)	Correct Factor(dB)	Result (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Degree (°)	Height (cm)	Remark
1	32.1795	23.55	8.41	31.96	40.00	-8.04	58	150	QP
2	277.0935	26.52	9.01	35.53	46.00	-10.47	326	100	QP
3	337.2155	26.64	10.14	36.78	46.00	-9.22	29	120	QP
4	547.0977	28.68	13.19	41.87	46.00	-4.13	359	100	QP

Test Specification: Vertical



No.	Frequency (MHz)	Reading (dBuV/m)	Correct Factor(dB)	Result (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Degree (°)	Height (cm)	Remark
1	32.4059	23.47	8.44	31.91	40.00	-8.09	51	100	peak
2	45.0583	20.74	8.14	28.88	40.00	-11.12	308	100	peak
3	155.9101	21.99	3.61	25.60	43.50	-17.90	120	100	peak
4	547.0977	27.52	13.19	40.71	46.00	-5.29	359	100	peak

\*\*\*\*\* END OF REPORT \*\*\*\*\*